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 Trust and Security in RFID-Based Product Authentication Systems Lehtonen, M.O.; Michahelles, F.; Fleisch, E.; Systems Journal, IEEE
 Volume 1, Issue 2, Dec. 2007 Page(s):129 - 144

IEEE JNL

 Product Authentication Service of Consumer's mobile RFID Device Juhan Kim; Dooho Choi; Inseop Kim; Howon Kim; Consumer Electronics, 2006. ISCE '06. 2006 IEEE Tenth International Symposium on 2006 Page(s):1 - 6

IEEE ONF

 A wireless service for product authentication in mobile RFID environment Juhan Kim; Howon Kim;
 Wireless Pervasive Computing, 2006 1st International Symposium on 16-18 Jan. 2006 Page(s):5 pp.

IEEE ONF

 Vendor Perceptions of How RFID can Minimize Product Shrinkage in the Retail Supply Chain Huber, N.; Michael, K.;
 RFID Eurasia, 2007 1st Annual
 5-6 Sept. 2007 Page(s):1 - 6

JEEE ONF

5. Digital watermark technique based on speech signal

Lv Jiu-ming; Luo Jing-qing; Yuan Xue-hua;

Computational Electromagnetics and Its Applications, 2004. Proceedings. ICCEA 2004. 2004 3rd International Conference on

1-4 Nov. 2004 Page(s):541 - 544

IEEE ONF

 Digital watermark technique of speech based on wavelet transform LV Jiuming; Luo Jingqing; Yuan Xuchua; Signal Processing, 2004. Proceedings. ICSP '04. 2004 7th International Conference on Volume 1, 31 Aug.-4 Sept. 2004 Page(s):605 - 608 vol.1

IEEE ONF

 CMOS unclonable system for secure authentication based on device variability Puntin, D.; Stanzione, S.; lannaccone, G.; Solid-State Circuits Conference, 2008. ESSCIRC 2008. 34th European 15-19 Sept. 2008 Page(s):130 - 133

IEEE ONF

A secure mobile track and trace system for anti-counterfeiting
Lei, P.; Claret-Tournier, F.; Chatwin, C.; Young, R.;
e-Technology, e-Commerce and e-Service, 2005. EEE '05. Proceedings. The 2005 IEEE International Conference on
29 March-1 April 2005 Page(s):686 - 689

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